

**Notice of References Cited**

Application/Control No.

09/469,987

Applicant(s)/Patent Under  
Reexamination  
SKARPNESS, MARK L.

Examiner

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Art Unit

2665

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,118,768 A	09-2000	Bhatia et al.	370/254
	B	US-6,061,450 A	05-2000	Bauer, William Dean	379/93.01
	C	US-6,208,637 B1	03-2001	Eames, Thomas R.	370/352
	D	US-6,347,075 B1	02-2002	Barzegar et al.	370/228
	E	US-5,838,682 A	11-1998	Dekelbaum et al.	370/401
	F	US-6,175,565 B1	01-2001	McKinnon et al.	370/354
	G	US-6,272,553 B2	08-2001	Way et al.	379/395
	H	US-6,088,430 A	07-2000	McHale, John F.	379/93.01
	I	US-5,999,612 A	12-1999	Dunn et al.	379/212.01
	J	US-5,892,764 A	04-1999	Riemann et al.	370/401
	K	US-5,940,479 A	08-1999	Guy et al.	379/93.01
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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